Erion Gjonaj



Technische Universität Darmstadt, Computational Electromagetics Laboratory (TEMF) Schlossgartenstr. 8 64289 Darmstadt, Germany

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Contents



- Emittance studies for the PITZ injector
 - Problem description
 - Simulation approaches
 - Results
 - Discussion
- Field map calculations
 - Mixed mesh high order FEM code
 - Field quality study for the 3.9 GHz 3rd harmonic cavity
- Summary





value

flat-top

rad.homogen

2/22\2

0,401

0,55

0.34

60,58

-1,116

-0,22808

20,6

0

1

24,64

0.60

57%

0,53

Problem description

Optimized machine parameters for Q = 1nC (simulations)

unit

ps

mm

eV

mm mrad

MV/m

MV/m

deg

nC

%

th./proj.em.

<sl.emit.>

MeV/c

mm mrad

mm mrad

deg

т

profile

distribution



talk from M. Krasilnikov, Zeuthen, 2011







Problem description

- Sources of discrepancy:
 - Thermal energy spread at cathode
 - Oxide layer effects and cathode impurities
 - Limited knowledge of machine conditions during measurement
 - Emittance measurement slit scan technique
 - Wakefields
 -
 - Improper modeling of radiation fields?
 - Inaccurate simulation of the emission process?





Problem description



- Boosted frame approach (ASTRA):
 - Retardation effects due to relative motion within bunch?
 - Acceleration radiation?
 - Relativistic correction for mirror charge fields?



Beam dynamics in the boosted frame



Problem description

Field of accelerated point charge:



- Retardation only wrt. mean bunch motion
- Effect is stronger when space charge is included
- charge is included
- (space charge free simulation) 1 Mean velocity 0,9 Velocity sheer 0.8 0.7 Beam uniformity 0,6 assumption violated few 0,5 mm away from cathode 0,4 0,3 0,2 0.1

1,2

1,4

1,6

1.8

2

Velocity sheer

Effect is stronger when mirror charges are considered

0

0

0,2

0,4

0,6

0,8

1

z / (cm)























Effect of retardation for single electron fields



Electron fields at fixed positions























Effect of retardation on single electron dynamics







Lienard-Wiechert particle-particle approach



- Store full particle history huge memory
- Search at every time step retarded times and positions for all particle positions - N_p² · N_t operations
- Full physics
- Accuracy depends only on
 - Time step
 - Number of particles





The PIC approach



Solve full set of Maxwell equations on the grid



Push particle positions and momenta



- Includes all effects; can handle arbitrary geometry
- Numerically more efficient then LW approach
- Accuracy depends on: <u>accuracy of field solution</u>, number of particles, current smoothing, time step,...





High order DG-FEM method

 Very accurate field solutions using piecewise high order polynomial approximation with grid cells (DG-FEM)*



* E. Gjonaj at al., New J. of Phys., Vol. 8, (2006), pp. 1-21





Charge conserving current interpolation

- Macroparticle current density:

 $\mathbf{j}(\mathbf{r},t) = \sum_{p} Q_{p} \mathbf{v}_{p}(t) W_{p} \left[\mathbf{r} - \mathbf{r}_{p}(t) \right]$

- DG-FEM current projection:

$$\mathbf{j}_{i}^{e}(t) = \sum_{p} Q_{p} \mathbf{v}_{p}(t) \int_{\Omega_{ep}(t)} d^{3} \mathbf{r} W_{p}(\mathbf{r}, t) \varphi_{i}^{e}(\mathbf{r})$$

- Discrete current / time step / cell:

$$\mathbf{J}_{i}^{e}(t^{n},t^{n+1}) = \int_{t^{n}}^{t^{n+1}} dt \, \mathbf{j}_{i}^{e}(t)$$



- Choice of particle size most critical parameter for simulation accuracy

















Beam dynamics in the gun: PIC simulations Q = 1 nCXY_rms = 0.75 mm Projected transverse emittance for non-optimized setup different approximation orders (data from 2010) 4 3,5 3 e_n / (mm mrad) 2,5 2 PIC - P1 PIC - P2 1,5 PIC - P3 $\Delta z = 1 \text{ mm}$ PIC - P4 1 $\Delta s = 10 \ \mu m$ 0,5 $N_{p} = 50.000$ 0 0,5 1,5 2,5 3 0 1 2 3,5 4,5 5 4 z / (cm)





































Beam dynamics for PITZ-1.8 setup Q = 1 nCPITZ-1.8 setup Projected transverse emittance for (M. Krasilnikov, 2011) no SPCH limiting at different XY_rms sizes XY_rms = 0.3 mm 2,5 2 en / (mm mrad) 1,5 XY rms = 0.6 mm 1 rms = 0.5 mm rms = 0.4 mm _rms = 0.3 mm 0,5 XY⁻rms = 0.3 mm, N_n = 1M XY rms = 0.3 mm dt = 0.05 ps0 3,5 0 0,5 1,5 2 2,5 3 4 4,5 5 5,5 z / (cm)





Beam dynamics for PITZ-1.8 setup

 Restarted ASTRA simulations with LW bunch as initial distribution



























Beam dynamics for PITZ-1.8 setup

- Still no good agreement with experiment
- Could extract full bunch charge at XY_rms = 0.3 mm
- Slightly larger emittance than ASTRA
- Emittance minimum and curve pattern same as ASTRA
- Are other effects responsible for the discrepancy (wakefields?)
- Restart positions too close to cathode backplane
- Longitudinal density oscillations not fully understood
- Convergence of LW vs. time step is unclear

















Discussion on space charge at the cathode



$$\frac{mv(x)v'(x)}{(1-\frac{v(x)^2}{c^2})^{3/2}} = F_0 + F_m(x), \quad v(0) = 0$$

$$F_m(x) = \frac{k e^{-\frac{2x^2}{\sigma^2}}}{\sqrt{2\pi}x\sigma} - \frac{k \operatorname{Erf}(\frac{\sqrt{2}x}{\sigma})}{4x^2}$$

Point charge emission from ideal surface not possible:

 Need a cloud mirror charge distribution

Main branch solution

$$v(x) = \sqrt{1 - \frac{16\pi^2 c^4 m^2 x^2 \sigma^2}{(\pi\sigma(4c^2 m x + k \operatorname{Erf}(\frac{\sqrt{2}x}{\sigma}) + 4F_0 x^2) - 2\sqrt{2\pi}kx)^2}}$$























- Minimum separation distance between particle and its mirror:
 - LW: ~time step
 - PIC: macroparticle shape
 - ASTRA: longitudinal grid step (?)
- Needs to be reduced at high charge densities: $\sigma < \lambda_D$
- but end up with individual particle interactions
 - No numerical convergence
- Only cure, increase number of particles in the simulation
 - Full charge extraction at 0.3 mm possible with ASTRA (?)





Field noise in eigenmode simulations



- Need huge amount of DoFs to compensate for mesh asymmetry
- Special treatment for the coupler kicks (PAC 2009, DESY / TEMF 2010)
- So far completely noise-free field maps only possible with Cartesian grids































































Thank you for your attention